

# SSC8L36PN6

## N-Channel Enhancement Mode MOSFET

#### Features

V <sub>DS</sub>	V <sub>GS</sub>	R <sub>DS(ON)</sub> Typ.	ID
30V ±		1.5mΩ@10V	196 Δ
	±20V	2.2mΩ@4.5V	186A

#### > Description

This device is N-Channel enhancement MOSFET. Uses SGT technology and design to provide excellent RDSON with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit.

100% UIS + ΔVDS + Rg Tested!

- Applications
- Motor Drive Control
- DCDC Conversion
- Power Supplies
- Synchronous Rectification

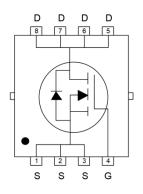
## > Ordering Information

Device	Package	Shipping	
SSC8L36PN6	PDFN5X6-8L	5000/Reel	

## > Pin Configuration



#### PDFN5X6-8L (Top View)



Pin Configuration



(XXYY: Internal Traceability Code)







Symbol	Parameter	Ratings	Unit	
V <sub>DSS</sub>	Drain-to-Source Voltage		30	V
V <sub>GSS</sub>	Gate-to-Source Volta	Gate-to-Source Voltage		V
	Continuous Duoin Current d	Tc <b>=25</b> ℃	186	^
ID	Continuous Drain Current <sup>d</sup>	Tc=100℃	103	A
Idsm	Continuous Drain Current <sup>a</sup>	T <sub>A</sub> =25℃	34	
		T <b></b> , <b>=70</b> ℃	24	A
Ідм	Pulsed Drain Current <sup>b</sup>		744	Α
_	Power Dissipation ° $\frac{T_{c}=25^{\circ}C}{T_{c}=100^{\circ}C}$	Tc <b>=25</b> ℃	83	14/
PD		33	W	
P <sub>DSM</sub>	Power Dissipation <sup>a</sup>	T <sub>A</sub> =25℃	2.8	14/
		T <b></b> , <b>=70</b> ℃	1.8	W
las	Avalanche Current <sup>b</sup> L=0.5mH Single Pulse		26	Α
Eas	Avalanche Energy <sup>b</sup> L=0.5mH Single Pulse		169	mJ
TJ	Operation junction temperature		-55~150	*0
Tstg	Storage temperature ra	-55~150	°C	

#### > Absolute Maximum Ratings ( $T_A=25^{\circ}C$ unless otherwise noted)

#### ➤ Thermal Resistance Ratings (T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
Reja	Junction-to-Ambient Thermal Resistance <sup>a</sup>	45	°C/W
R <sub>θJC</sub>	Junction-to-Case Thermal Resistance	1.5	C/ <b>V</b>

Note:

- a. The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz.copper, in a still air environment with T<sub>A</sub>=25 °C.The value in any given application depends on the user is specific board design. The power dissipation is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.

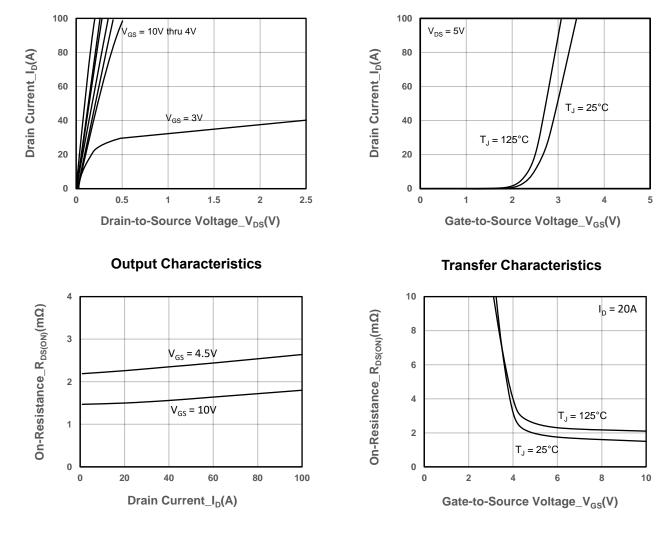


# > Electrical Characteristics (T\_A=25 $^\circ\!\!\!{\rm C}$ unless otherwise noted)

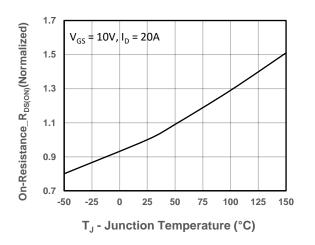
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V(BR)DSS	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA	30			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250 uA$	1.0	1.7	2.5	V
Durain Courses On Desistence	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 20A		1.5	2	
Drain-Source On-Resistance		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 15A		2.2	3.7	- mΩ
Zero Gate Voltage Drain Current	loss	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V			1	μA
Gate-Source Leak Current	lgss	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
Transconductance	G <sub>FS</sub>	V <sub>DS</sub> = 5V, I <sub>D</sub> = 10A		21		S
Forward Voltage	Vsd	V <sub>GS</sub> = 0V, I <sub>S</sub> = 20A		0.8	1.3	V
Gate Resistance	Rg	V <sub>DS</sub> = 0V, f = 1MHz		1.7		Ω
Input Capacitance	Ciss	$\gamma = 4\Sigma / \gamma = 0/2$		2900		pF
Output Capacitance	Coss	$V_{DS} = 15V, V_{GS} = 0V,$		2550		
Reverse Transfer Capacitance	Crss	- f = 1MHz		150		
Total Gate Charge	Q <sub>G</sub>			55		
Gate to Source Charge	Q <sub>GS</sub>	$V_{GS} = 10V, V_{DS} = 15V,$ $I_{D} = 20A$		8		nC
Gate to Drain Charge	Q <sub>GD</sub>			11		-
Turn-on Delay Time	T <sub>D(ON)</sub>			8		
Rise Time	Tr	V <sub>GS</sub> = 10V, V <sub>DS</sub> = 15V,		6		
Turn-off Delay Time	T <sub>D(OFF)</sub>	I <sub>D</sub> = 20Α, R <sub>G</sub> = 3Ω		34		ns
Fall Time	T <sub>f</sub>			10		
Diode Recovery Time	Trr	I <sub>F</sub> =20A, di/dt=500A/us		25		ns
Diode Recovery Charge	Qrr	I <sub>F</sub> =20A, di/dt=500A/us		60		nC



## > Typical Performance Characteristics ( $T_A=25^{\circ}C$ unless otherwise noted)

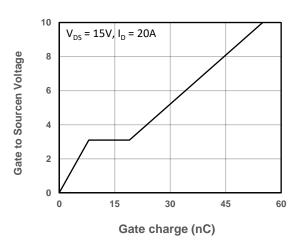


#### **On-Resistance vs. Drain Current and Gate Voltage**



#### **On-Resistance vs. Junction Temperature**

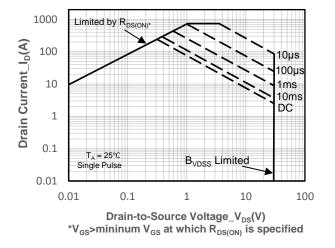
On-Resistance vs. Gate-to-Source Voltage



#### Gate-Source Voltage vs. Gate charge

4 / 7



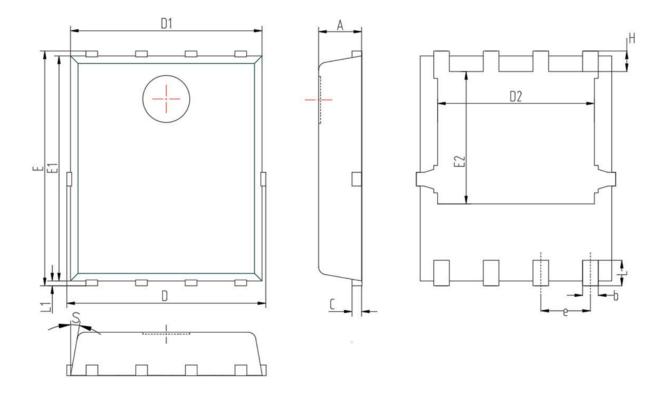


Safe Operating Area vs. Junction-to-Ambient





## > Package Information



Symbol	MILL IMETER			
	Min	Nom	Max	
A	0.90	1.05	1.20	
b	0.25	0.30	0.51	
С	0.15	0.25	0.35	
D	4.80	5.10	5.40	
D1	4.80	5.00	5.20	
D2	3.70	4.00	4.30	
E	5.80	6.15	6.50	
E1	5.50	5.75	5.95	
E2	3.30	3.45	3.67	
е	1.27BSC			
Н	0.40	0.60	0.93	
L	0.45	0.65	0.85	
L1	0.00	0.10	0.25	
S	0°		12°	



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